

RATING	SYMBOL	D44T1,2	D44T3,4	UNITS Volts	
Collectc -Emitter Voltage	VCEO	250	300		
Collector-Emitter Voltage	VCES	300	400	Volts	
Emitter Base Voltage	VEBO	5	5 5		
Collector Current — Continuous	lc	2	2	A	
Base Current — Continuous	IB	0.5	0.5	A	
Total Power Dissipation @ $T_A = 25^{\circ}C$ @ $T_C = 25C$	PD	2.1 31.2	2.1 31.2	Watts	
Operating and Storage Junction Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	-55 to +150	°C	

## thermal characteristics

Thermal Resistance, Junction to Ambient	R <sub>ØJA</sub>	60	60	°C/W
Thermal Resistance, Junction to Case	R <sub>ØJC</sub>	R <sub>ØJC</sub> 4		°C/W
Maximum Lead Temperature for Soldering Purpose: 1/6" from Case for 5 Seconds	т	260	260	°C



NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.

## **Quality Semi-Conductors**

## electrical characteristics ( $T_C = 25^{\circ}C$ ) (unless otherwise specified)

CHARACTERISTIC		SYMBOL	MIN	TYP	MAX	UNIT
off characteristics <sup>(1)</sup>						
Collector-Emitter Breakdown Voltage (I <sub>C</sub> = 10 μA)	D44T1,2 D44T3,4	BVCES	300 400	-	_	Volts
Collector Cutoff Current (V <sub>CE</sub> = Rated V <sub>ECS</sub> )		ICES	_		10	μA
Emitter Cutoff Current (V <sub>EB</sub> = 5V)		IEBO	_		10	μA
second breakdown						
Second Breakdown with Base Forward Biased		FBSOA	SEE FIGURE 5			
on characteristics(1)						
DC Current Gain $(I_C = 500mA, V_{CE} = 10V)$ $(I_C = 50mA, V_{CE} = 10V)$ $(I_C = 500mA, V_{CE} = 10V)$ $(I_C = 50mA, V_{CE} = 10V)$	D44T1,3 D44T2,4	hfe	30 40 75 40			
Collector-Emitter Saturation Voltage (I <sub>C</sub> = 500mA, I <sub>B</sub> = 50mA)		V <sub>CE(sat)</sub>	_		1.0	v
Base Emitter Saturation Voltage (I <sub>C</sub> = 500mA, I <sub>B</sub> = 50mA)		V <sub>BE(sat)</sub>	_		1.2	v
dynamic characteristics						
Collector Capacitance (V <sub>CB</sub> = 10V, f = 1 MHz)		C <sub>cb</sub>	—	25	-	pF
Current Gain — Bandwidth Product (I <sub>C</sub> = 100mA, V <sub>CE</sub> = 10V, f <sub>test</sub> = 1.0 MHz))		fT	—	45	-	MHz

## switching characteristics

Resistive Load						
Delay Time + Rise Time	I <sub>C</sub> = 500mA, I <sub>B1</sub> = I <sub>B2</sub> = 50mA	t <sub>d</sub> + t <sub>r</sub>		0.2	_	μs
Storage Time	V <sub>CC</sub> = 50V, t <sub>p</sub> = 25µsec	ts	_	3.3	-	
Fall Time		t <sub>f</sub>	—	0.6	—	

(1) Pulse Test: Pulse Width -  $300\mu$ s Duty Cycle  $\leq 2\%$ .

